

FOR LCD MODULE

MODULE NO: AFK240400A0-3.2N6NTM REVISION NO: V01

Customer's Approval:		
	SIGNATURE	DATE
PREPARED BY (RD ENGINEER)		
CHECKED BY	·	
APPROVED BY		

Records of Revision

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1. Introduction

1.1 Scope of application

This specification applies to the positive type TFT transmissive dot matrix LCD module.

LCD resolution: Dots 240*RGBx400.

As to basic specification of the driver IC, refer to the IC (ST7793) data sheet.

1.2 Structure:

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Structure: TFT Panel+Polarizer+IC+FPC+BL;
Full 262K Color 3.2 inch TFT Panel;
One bare chip with gold bump (COG) TECH;
White LED back light;
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1.3 TFT features:

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Transmissive Type LCD, normally white; 240 dot-source and 400 dot-gate outputs; Optimum viewing direction:6 o' clock; Support MCU and RGB interface mode;
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1.4 Applications:

Mobile phone

PSP

PDA

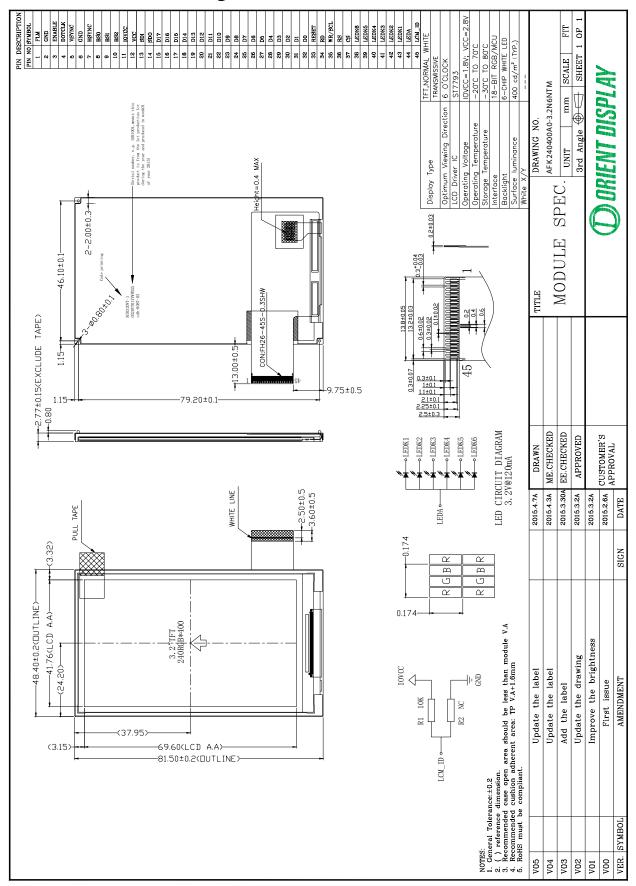
GPS

Etc...

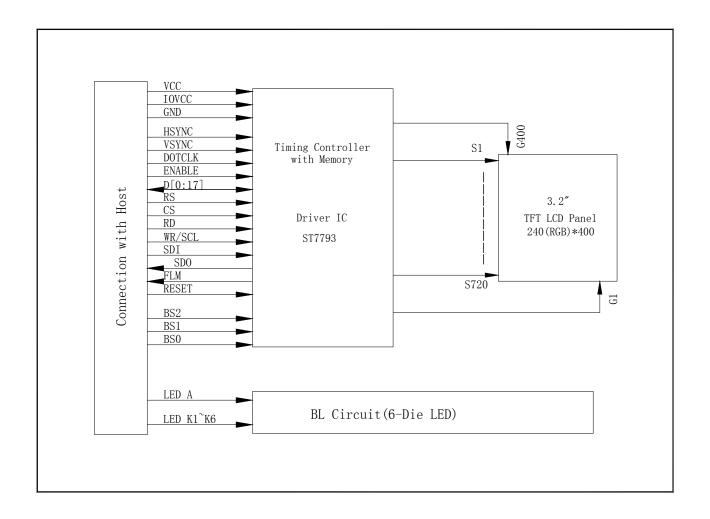
2. General specification

ITEM	Standard value	UNIT
Display Mode	Transmissive, Normally white	
Driver Mothod	TFT Active matrix	
Number of Dots	240 (RGB) *400	Dots
Pixel Arrangement	RGB Vertical Stripe	
Active Area	41. 76*69. 60	mm
Optimum Viewing Direction	6	o' clock
Gray Scale Inversion	12	o' clock
Direction	12	O CIOCK
Driver IC	ST7793	
Module Size(W*H*T)	48. 40*81. 50*2. 77	mm
Approx. Weight	TBD	g
Back Light	White LED	
System interface	MCU & RGB	

3. Mechanical drawing



4. BLOCK DIAGRAM



5. Interface Pin Function

	11400 1							
Pin No.	Symbol	Description						
		Output a frame head pulse signal is used as synchronies MCU						
1	FLM	to frame rate.						
		If not used, leave this pin open.						
2	GND	Power ground.						
3	ENABLE	Data enable signal for RGB interface operation.						
0	LIMDLL	If not used, please fix this pin at VDDI or DGND level.						
4	DOTCLK	Dot clock signal for RGB interface operation.						
1	DOTOLIN	If not used, please fix this pin at VDDI or DGND level.						
		Vertical (Frame) synchronizing input signal for RGB						
5	VSYNC	interface operation.						
		Fix to the GND level when not in use.						
6	GND	Power ground.						
		Horizontal (Line) synchronizing input signal for RGB						
7	HSYNC	interface operation.						
		Fix to the VDDI or GND level when not in use.						
8	BS0							
9	BS1	Interface mode select.						
10	BS2							
11	IOVCC	Digital I/O Pad power supply.						
12	VCC	Analog power supply.						
		SPI interface input pin.						
13	SDI	The data is latched on the rising edge of the SCL signal.						
		If not used, please fix this pin at IOVCC or GND level.						
		SPI interface output pin.						
14	SD0	The data is outputted on the falling edge of the SCL signal.						
		If not used, please fix this pin at floating.						
15~32	$\mathrm{D}17^{\sim}\mathrm{D}0$	Data bus.						
		This signal will reset the device and it must be applied to						
33	RESET	properly initialize the chip.						
		Signal is active low.						
0.4	חח	Read enable in 8080 MCU parallel interface. Low-active.						
34	RD	If not used, please fix this pin at IOVCC or GND level.						
		Write enable in MCU parallel interface.						
35	WR/SCL	In SPI mode, this pin is used as SCL.						
		If not used, please fix this pin at IOVCC level.						
		Display data/command selection (RS) pin in MCU interface.						
36	RS	RS=1: display data or parameter.						
		RS=0: register index / command.						

		If not used, please fix this pin at IOVCC or GND level.
37	CS	Chip selection pin. Low-active.
31	CS	If not used, please fix this pin at IOVCC level.
38	LEDK6	Cathode of LED backlight.
39	LEDK5	Cathode of LED backlight.
40	LEDK4	Cathode of LED backlight.
41	LEDK3	Cathode of LED backlight.
42	LEDK2	Cathode of LED backlight.
43	LEDK1	Cathode of LED backlight.
44	LEDA	Anode of LED backlight.
45	LCM_ID	Customer define PIN(default connect to IOVCC).

Note: Interface mode select:

BS2	BS1	BS0	Interface Mode	Data Pin
0	0	0	8080 18-bit interface	D[17:0]
0	0	1	8080 9-bit interface	D[17:9]
0	1	0	8080 16-bit interface	D[17:10], D[8:1]
0	1	1	8080 8-bit interface	D[17:10]
1	0	ID	SPI	SDI, SDO

When the SPI interface is selected, BSO pin is used for the ID setting.

6. ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Min	Max	Unit
Supply voltage for logic	IOVCC	-0.3	4. 6	V
Supply voltage for analog	VCC	-0.3	4. 6	V
Input voltage	VIN	-0.3 VCC+0.3		V
Supply current (One LED)	${ m I}_{\scriptscriptstyle m LED}$		30	mA
Operating temperature	T_{OP}	-20	+70	°°C
Storage temperature	T_{ST}	-30	+80	°C

7. ELECTRICAL CHARACTERISTICS

For IC

Item	Symbol	Min	Тур	Max	Unit	Applicable terminal
Supply voltage for logic	IOVCC	1.65	1.8	VCC	V	
Supply voltage for analog	VCC	2. 5	2. 75	3. 3	V	
Input voltage	VIL	GND	-	0.2IOVCC	V	
Thout voltage	VIH	0.8I0VCC	-	IOVCC	V	
Input leakage current	${ m I}_{ t LKG}$	-0.1		0. 1	μА	

For backlight

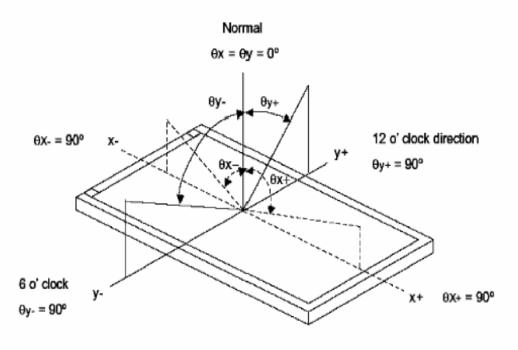
Item	Symbol	Min	Тур	Max	Unit	Condition
Supply Current	I		120		mA	
Forward Voltage	V_{LED}	3. 0	3. 2	3. 4	V	I=120mA
Power Consumption	Р		384		mW	
Life Time		20000			Hours	Note

Note: Brightness to be decreased to 50% of the initial value at ambient temperature TA=25°C

8. OPTICAL CHARACTERISTICS

TTEM	ITEM		CONDITIONS	SPEC	CIFICAT	IONS	UNIT	NOTE
		SYMBOL CONDITIONS		MIN.	TYP.	MAX	UNII	NOIE
Brightness		В		-	400	_	Cd/m ²	
Contrast Ra	tio	CR			350			
Response Ti	me	Tr+Tf			20	30	ms	
	Red	XR						
		YR	Viewing					
CIE	Green	XG	normal angle					
CIE		YG						
Color coordinate	Blue	Хв						
Coordinate		YB						
	White	Xw						
		Yw						
	Hor.	$ heta_{\scriptscriptstyle X+}$			70			
Viewing		$\theta_{\scriptscriptstyle X-}$	Center		70		, n	
Angle	Ver.	$\theta_{\scriptscriptstyle Y+}$	CR>=10		70		Deg.	
		$ heta_{\scriptscriptstyle Y-}$			60			
Uniformity	Un			80			%	

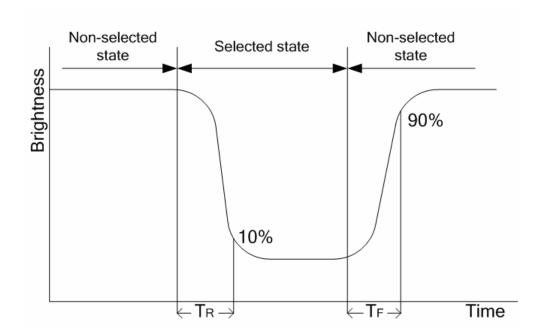
Note 1 : Definition of Viewing Angle xand x :



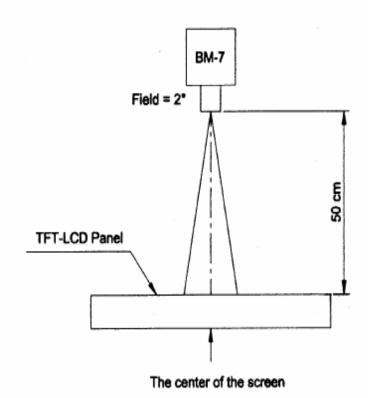
Note 2: Definition of contrast ratio CR:

CR= Brightness of non-selected dots (white)
Brightness of selected dots (black)

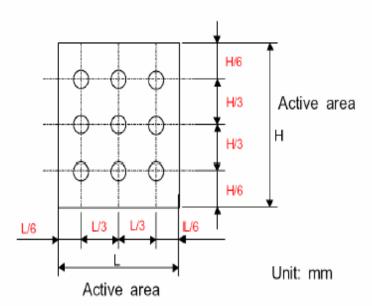
Note 3: Definition of response time (TR, TF)



The brightness test equipment setup 20mA Field=2° (As measuring "black" image, field=2° is the best testing condition)



Note 4:



9. Timing characteristics

9.1 8080 series MCU parallel interface Characteristics:18/16/9/8-bit bus

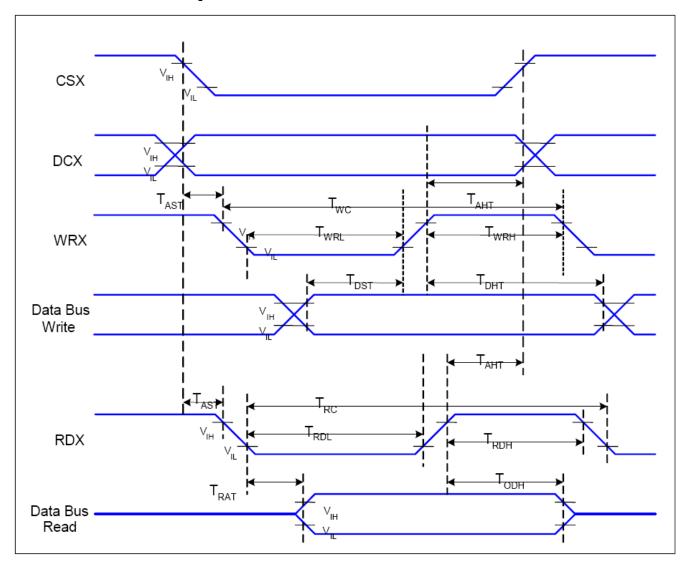


Figure 1. Parallel interface timing characteristics (8080-Series MCU)

IOVCC=1.65 to VCC, VCC=2.5 to 3.3V, AGND=DGND=OV, Ta=23 $^{\circ}\mathrm{C}$

Signal	Symbol	Parameter	Min	Max	Unit	Description
DCX	TAST	Address Setup Time	0		ns	
DCX	TAHT	Address Hold Time (Write/Read)	2		ns	
	TWC	Write Cycle	75		ns	
WRX	TWRH	Control Pulse "H" Duration	25		ns	
	TWRL	Control Pulse "L" Duration	30		ns	
	TRC	Read Cycle (ID)	450		ns	
RDX	TRDH	Control Pulse "H" Duration (ID)	250		ns	When Read ID Data
	TRDL	Control Pulse "L" Duration (ID)	170		ns	

Signal	Symbol	Parameter	Min	Max	Unit	Description
	TDST	Data Setup Time	20	1	ns	TRAT, TRATFM: 3K
DD[17:0]	TDHT	Data Hold Time	10	ŀ	ns	ohm Pull up or Down and 30pF Parallel
DB[17:0]	TRAT	Read Access Time (ID)	1	150	ns	Cap. To GND. TODH: 3K ohm Pull
	TODH Output Disable Time	10		ns	up or Down.	

Figure 2. 8080 parallel interface characteristics

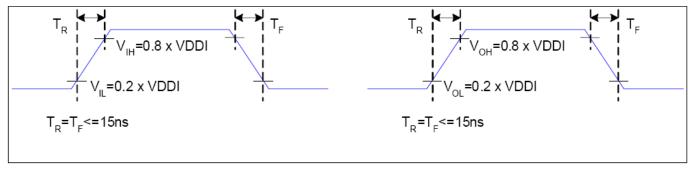


Figure 3. Rising and falling timing for I/O signal

Note: The rising time and falling time (Tr, Tf) of input signal and fall time are specified at 15 ns or less. Logic high and low levels are specified as 20% and 80% of IOVCC for Input signals.

9.2 Serial Interface Characteristics

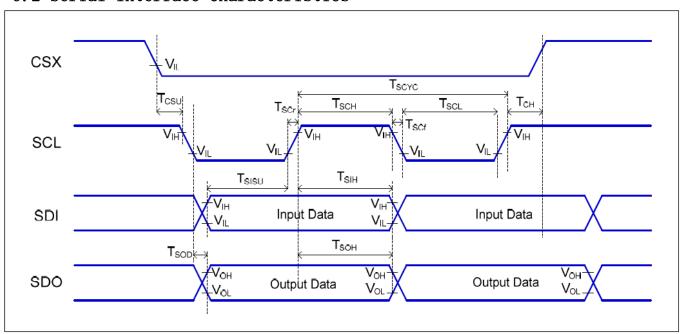


Figure 4. SPI interface timing Characteristics

IOVCC=1.65 to VCC, VCC=2.5 to 3.3V, AGND=DGND=0V, Ta=23 $^{\circ}\text{C}$

Signal	Symbol	Parameter	Min	Max	Unit	Description
CSX	TCSU	Chip Select Setup Time	20		ns	
CSX	TCH	Chip Select Hold Time	60		ns	-
	TSCH	SCL "H" pulse width (Write)	40		ns	
	TSCH	SCL "H" pulse width (Read)	150		ns	
SCL	TSCYC	Serial clock cycle (Write)	100		ns	
SCL	TSCYC	Serial clock cycle (Read)	350		ns	
	TSCL	SCL "L" pulse width (Write)	40		ns	
	TSCL	SCL "L" pulse width (Read)	150		ns	
eDI.	TSISU	Serial Input Data Setup Time	30		ns	
SDI	TSIH	Serial Input Data Hold Time	30		ns	
000	TSOD	Serial Output Data Setup Time		130	ns	
SDO	TSOH	Serial Output Data Hold Time	10		ns	

Figure 5. SPI interface Characteristics

9.3 RGB Interface Characteristics

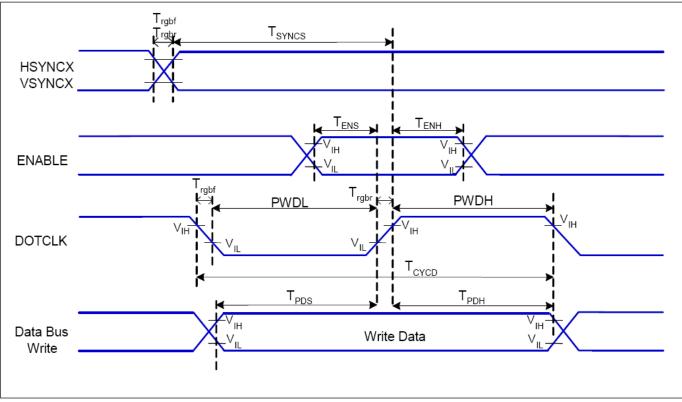


Figure 6. RGB Interface timing Characteristics

IOVCC=1.65 to VCC, VCC=2.5 to 3.3V, AGND=DGND=0V, Ta=23 $^{\circ}\!\text{C}$

Signal	Symbol	Parameter	MIN	MAX	Unit	Description
HSYNCX	TSYNCS	VSYNC, HSYNC Setup Time	20		20	
VSYNCX	1011100	VSTNC, HSTNC Setup Tillle	30	-	ns	
ENABLE	TENS	Enable Setup Time	30	-	ns	
ENABLE	TENH	Enable Hold Time	30	-	ns	
	PWDH	DOTCLK High-level Pulse Width	40	-	ns	
DOTCLK	PWDL	DOTCLK Low-level Pulse Width	40	-	ns	
	TCYCD	DOTCLK Cycle Time	100	-	ns	
DB	TPDS	PD Data Setup Time	40	-	ns	
DB	TPDH	PD Data Hold Time	40	-	ns	

Figure 7. RGB Interface Characteristics

9.4 Reset input Timing

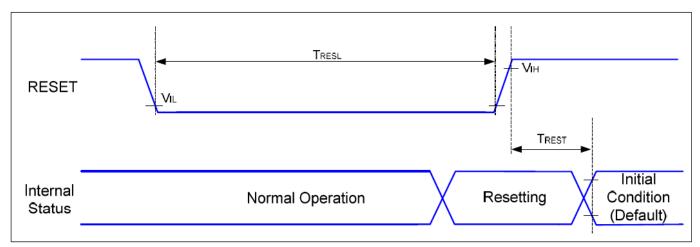


Figure 8. Reset Timing Characteristics

IOVCC=1.65 to VCC, VCC=2.5 to 3.3V, AGND=DGND=0V, Ta=23 $^{\circ}\mathrm{C}$

Signal	Symbol	Parameter	Min	Max	Unit	Description
RESET	TRESL	Reset Low Level Width	1	-	ms	
	TREST	Reset Complete Time	1		ms	-

Figure 9. Reset Characteristics

10. Standard Specification for Reliability:

10-1. Standard Specifications for Reliability of LCD Module

No	Item	Description			
01	High temperature operation	The sample should be allowed to stand at $70^{\circ}\mathrm{C}$ for 240 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours.			
02	Low temperature operation	The sample should be allowed to stand at $-20^\circ\mathrm{C}$ for 240 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours.			
03	High temperature storage	The sample should be allowed to stand at $80^{\circ}\mathrm{C}$ for 240 hours under noload condition, and then returning it to normal temperature condition, and allowing it stand for 2 hours.			
04	Low temperature storage	The sample should be allowed to stand at -30°C for 240 hours under no-load condition, then returning it to normal temperature condition, and allowing it stand for 2 hours.			
05	Moisture storage	The sample should be allowed to stand at 60°C , $90\%\text{RH}$ MAX for 240 hours under no-load condition, then taking it out and drying it at normal temperature for 2 hours.			
06	Thermal shock storage	The sample should be allowed to stand the following 10 cycles : $-30^{\circ}\!$			
07	Packing vibration	Frequency range : 10Hz $^{\sim}$ 55Hz Amplitude of vibration : 1.5mm Sweep time: 12 min X, Y, Z 2 hours for each direction.			
08	Packing drop test	According to ISTA 1A 2001.			
09	Electrical Static Discharge	Air: $\pm 4 \text{KV} \ 150 \text{pF}/330 \Omega$ 5 times			
	DISCHARGE	Contact: $\pm 2 \text{KV} 150 \text{pF}/330 \Omega$ 5 time			

^{*}Sample size for each test item is 3~5pcs

10 - 2. Testing Conditions and Inspection Criteria

For the final test the testing sample must be stored at room temperature for 24 hours, after the tests listed in Table 12.2, Standard specifications for Reliability have been executed in order to ensure stability.

No	Item	Test Model	In section Criteria
01	Current Consumption	Refer To Specification	The current consumption should conform to the product specification.
02	Contrast	Refer To Specification	After the tests have been executed, the contrast must be larger than half of its initial value prior to the tests.
03	Appearance	Visual inspection	Defect free.

10-3. MTBF

MTBF	Functions, performance, appearance, etc. shall be free from remarkable deterioration within10,000 hours under ordinary operating and storage conditions room temperature (25 \pm 5°C), normal humidity (50 \pm 10% RH), and in area not exposed to direct sun light.
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11. Specification of Quality Assurance:

11-1. Purpose

This standard for Quality Assurance should affirm the quality of LCD module products to supply to purchaser by Orient Display.

- 11-2. Standard for Quality Test
 - a. Inspection:

Before delivering, the supplier should take the following tests, and affirm the quality of product.

b. Electro-Optical Characteristics:

According to the individual specification to test the product.

c. Test of Appearance Characteristics:

According to the individual specification to test the product.

d. Test of Reliability Characteristics:

According to the definition of reliability on the specification for testing products.

e. Delivery Test:

Before delivering, the supplier should take the delivery test.

- (i) Test method: According to MIL-STD105E. General Inspection Level II take a single time.
- (ii) The defects classify of AQL as following:

Major defect: AQL = 0.65 Minor defect: AQL = 2.5

Total defects: AQL = 2.5 (MASS PRODUCTION FAILURE RATE: 5000~7000PPM)

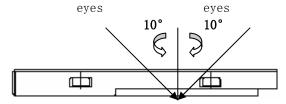
- 11-3. Non-conforming Analysis & Deal With Manners
- a. Non- conforming Analysis:
 - (i) Purchaser should supply the detail data of non-conforming sample and the non-conforming.
 - (ii) After accepting the detail data from purchaser, the analysis of non-conforming should be finished in two weeks.
 - (iii) If supplier can not finish analysis on time, must announce purchaser before 3 days.
- b. Disposition of non-conforming:
 - (i) If find any product defect of supplier during assembly time, supplier must change the good product for every defect after recognition.
 - (ii) Both supplier and customer should analyze the reason and discuss the disposition of non-conforming when the reason of nonconforming is not sure.
- 11-4. Agreement items

Both sides should discuss together when the following problems happen.

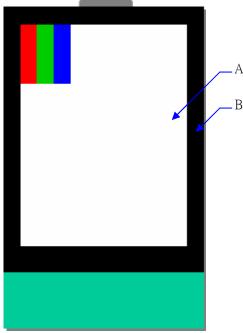
- a. There is any problem of standard of quality assurance, and both sides should think that must be modified.
- b. There is any argument item which does not record in the standard of quality assurance.
- c. Any other special problem.

11-5. Standard of The Product Appearance Test

- a. Manner of appearance test:
- (i) The test must be under 20W \times 2 or 40W fluorescent light, and the distance of view must be at 30 ± 5 cm.
 - (ii) When test the model of transmissive product must add the reflective plate.
 - (iii) The test direction is base on around $10^{\circ}\,$ of vertical line.
 - (iiii) Temperature: $25\pm5^{\circ}$ C Humidity: $60\pm10^{\circ}$ RH



(iv) Definition of area:



- A. Area: Viewing area.
- B. Area: Out of viewing area. (Outside viewing area)
- b. Basic principle:
 - (i) It will accord to the AQL when the standard can not be described.
- (ii) The sample of the lowest acceptable quality level must be discussed by both supplier and customer when any dispute happened.
- (iii) Must add new item on time when it is necessary.
- c. Standard of inspection: (Unit: mm)

11-6. Inspection specification

NO	Item	Criterion	AQL			
01	Electrical Testing	1 Missing vertical, horizontal segment, segment contrast defect2 Missing character, dot or icon3 Display malfunction4 No function or no display5 Current consumption exceeds product specifications6 LCD viewing angle defect7 Mixed product types8 Flicker				
02	Black or White spots or Bright spots or Color spots on LCD (Display only)	 2.1 White and black or color spots on display ≤ 0.25mm, no more than Five spots. 2.2 Densely spaced: No more than three spots within 3mm. 	2. 5			
	LCD and Touch Panel black spots,	3.1 Round type: As following drawing $\Phi = (X+Y) / 2$ $\begin{array}{c ccccccccccccccccccccccccccccccccccc$	2. 5			
03	white spots, contamination (non - display)	Length(m Width(mm) Acceptable Q'ty m) $$ $W \le 0.02$ Accept no dense $L \le 3.0$ $0.02 < W \le 0.05$ $L \le 2.5$ $0.03 < W \le 0.08$ $0.08 < W$ Rejection $0.08 < W$ Rejection $0.08 < W$ $0.08 < W$	2. 5			

NO	Item	Criterion				
04	Polarizer bubbles	If bubbles are visible, judge using black spot specifications, not easy to find, must check in specify direction $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	2. 5			
05	Scratches	Follow NO. 3 -2 Line Type.				
06	Chipped glass	Symbols: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: LCD side length L: Electrode pad length 6.1 General glass chip: 6.1.1 Chip on panel surface and crack between panels: z: Chip thickness y: Chip width x: Chip length Z≤1/2t Not over viewing area x≤1/8a 1/2t< z≤2t Not exceed 1/3k x≤1/8a O Unit: mm If there are 2 or more chips, x is the total length of each chip 6.1.2 Corner crack: z: Chip thickness y: Chip width x: Chip length Z≤1/2t Not over viewing area x≤1/8a Not exceed 1/3k x≤1/8a Z≤1/2t Not over viewing area x≤1/8a Not exceed 1/3k x≤1/8a Unit: mm O Unit: mm If there are 2 or more chips, x is the total length of each chip	2. 5			

NO	Item	Criterion	AQL
NO	Item Glass crack	$ \begin{array}{c} \text{Symbols:} \\ \text{x: Chip length} \\ \text{x: Chip length} \\ \text{y: Chip width} \\ \text{t: Glass thickness} \\ \text{a: LCD side length} \\ \text{1.2 Protrusion over terminal:} \\ \text{7.2.1 Chip on electrode pad:} \\ \hline \\ \text{y: Chip width} \\ \text{x: Chip length} \\ \hline \\ \text{x: Chip thickness} \\ \hline \\ \text{y} \leq 0.5 \text{mm} \\ \hline \\ \text{x} \leq 1/8 \text{a} \\ \hline \\ \text{y: Chip width} \\ \hline \\ \text{x: Chip thickness} \\ \hline \\ \text{y} \leq 1.5 \text{conductive portion:} \\ \hline \\ \text{y: Chip width} \\ \hline \\ \text{x: Chip length} \\ \hline \\ \text{x: Chip thickness} \\ \hline \\ \text{y: Chip width} \\ \hline \\ \text{x: Chip length} \\ \hline \\ \text{x: Chip thickness} \\ \hline \\ \text{y} \leq 1.5 \text{conductive portion:} \\ \hline \\ \text{y: Chip width} \\ \hline \\ \text{x: Chip length} \\ \hline \\ \text{x: Chip thickness} \\ \hline \\ \text{y} \leq 1.5 \text{conductive portion:} \\ \hline \\ \text{OIf there chipped area touches the ITO terminal, over 2/3 of the ITO} \\ \hline \\ \text{OIf there chipped area touches the ITO terminal, over 2/3 of the ITO} \\ \hline \\ \hline \\ \text{Thickness} \\ \hline \\$	AQL 2. 5
		 must remain and be inspected according to electrode terminal specifications. ⊙ If the product will be heat sealed by the customer, the alignment mark must mot be damaged. 7. 2. 3 Substrate protuberance and internal crack y: width x: length 	
		y ≤ 1/3L	

NO	Item	Criterion	AQL
08	Cracked glass	The LCD with extensive crack is not acceptable.	2. 5
09	Backlight elements	9.1 Illumination source flickers when lit.9.2 Spots or scratches that appear when lit must be judged. Using LCD spot, lines and contamination standards.9.3 Backlight doesn't light or color is wrong.	2. 5 2. 5 0. 65
10	Bezel	Bezel must comply with product specifications.	2. 5
11	PCB、COB	 11.1 COB seal may not have pinholes larger than 0.2mm or contamination. 11.2 COB seal surface may not have pinholes through to the IC. 11.3 The height of the COB should not exceed the height indicated in the assembly diagram. 11.4 There may not be more than 2mm of sealant outside the seal area on PCB. And there should be no more than three places. 11.5 Parts on PCB must be the same as on the production characteristic chart, There should be no wrong parts, missing parts or excess parts. 11.6 The jumper on the PCB should conform to the product characteristic chart. 	2. 5 2. 5 2. 5 2. 5 0. 65
12	FPC	12.1 FPC terminal damage $\leq 1/2$ FPC terminal width and can not affect the function , we judge accept. 12.2 FPC alignment hole damage $\leq 1/2$ alignment area and can not affect the function , we judge accept.	2. 5 2. 5
13	Soldering	13.1 No cold solder joints, missing solder connections, oxidation or icicle.13.2 No short circuits in components on PCB or FPC.	2. 5 0. 65

NO	Item	Criterion	AQL
NO 14	Touch Panel Chipped glass	Symbols: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Touch Panel Total thickness a: LCD side length L: Electrode pad length 14.1 General glass chip: 14.1.1 Chip on panel surface and crack between panels: z: Chip thickness y: Chip width x: Chip length ≤1/2 k and not over viewing area x≤1/8a Unit: mm If there are 2 or more chips, x is the total length of each chip 14.1.2 Corner crack:	AQL 2. 5
		z: Chip thickness y: Chip width x: Chip length	

NO	Item	Criterion	AQL
15	Touch Panel(Fish eye、dent and bubble on film)	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	2. 5
16	Touch Panel Newton ring	Newton ring dimension $\leq 1/2$ touch panel area and not affect font and line distortion($\leq 2.5\%$), it is acceptable.	2. 5
17	Touch Panel Linearity	Less than 2.5% is acceptable.	2. 5
18	LCD Ripple	Touch the touch panel , can not see the LCD ripple. Pen: R 1.0mm silicon rubber. Operation Force: 80g	2. 5
19	General appearance	 19.1 Pin type must match type in specification sheet. 19.2 LCD pin loose or missing pins. 19.3 Product packaging must the same as specified on packaging specification sheet. 19.4 Product dimension and structure must conform to product specification sheet. 	0. 65 0. 65 0. 65 0. 65

12. Handling Precaution:

12-1 Handling of LCM

- Don't give external shock.
- Don't apply excessive force on the surface.
- Liquid in LCD is hazardous substance. Must not lick and swallow.
 when the liquid is attach to your hand, skin, cloth etc.
 Wash it out thoroughly and immediately.
- Don't operate it above the absolute maximum rating.
- Don't disassemble the LCM.
- The operators should be grounded whenever he/she comes into contact with the module. Never touch any of the conductive parts such as the LSI pads, the copper leads on the PCB and the interface terminals with any parts of the human body.
- The modules should be kept in antistatic bags or other containers resistant to static for storage.
- The module is coated with a film to protect the display surface. Be care when peeling off this protective film since static electricity may be generated.

12-2 Storage

- Store in an ambient temperature of $25\pm10^{\circ}$ C, and in a relative humidity of $50\pm10^{\circ}$ RH. Don't expose to sunlight or fluorescent light.
- Storage in a clean environment, free from dust, active gas, and solvent.
- Store in anti-static electricity container.
- Store without any physical load.

11-3 Soldering

- Use only soldering irons with proper grounding and no leakage.
- Iron: No higher than $280\pm10^{\circ}$ C and less than 3 sec during Hand soldering.
- Rewiring: no more than 2 times.

13 Packing method

----TBD